Search Notes

Applic	ation/	Contro	l No.
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Applicant(s)/Patent under Reexamination

10/774,976

BELCHER, WAYNE Art Unit

Examiner

1722

Emmanuel S. Luk

SEARCHED				
Class	Subclass	Date	Examiner	
425	458	4/29/2006	EL	
15	105.5	4/29/2006	EL	
15	236.01	4/29/2006	EL	
15	236.07	4/29/2006	EL	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST text search	4/29/2006	EL	
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